



# Power MOSFETS

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## DATASHEET

**LM40016NAK8A**

N-Channel  
Enhancement Mode MOSFET

-  Leadpower-semiconductor Corp., Ltd
-  sales@leadpower-semi.com
-  (03) 6577339 FAX : (03) 6577229
-  [www.leadpower-semi.com](http://www.leadpower-semi.com)



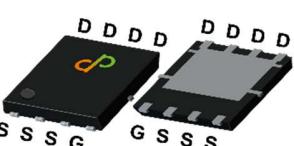
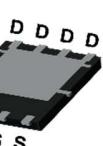
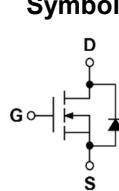
Quality Management Systems  
ISO 9001:2015 Certificate

# LM40016NAK8A

## N-Channel Enhancement Mode MOSFET

### Pin Description

### Product Summary

PDFN5*6	Symbol	Symbol	N-Channel	Unit
Top View 			$V_{DSS}$	40
			$R_{DS(ON)-Max}$	1.6
			ID	142

### Feature

- Fast switching speed
- Reliable and Rugged
- ROHS Compliant & Halogen-Free
- 100% UIS and Rg Tested

### Applications

- DC-to-DC converters
- Switch Mode Power Supply
- Brushless DC motor control
- Battery protection

### Ordering Information

Orderable Part Number	Package Type	Form	Shipping	Marking
LM40016NAK8A	PDFN5*6	Tape & Reel	5000 / Tape & Reel	40016 <input type="checkbox"/> <input type="checkbox"/> <input type="checkbox"/> <input type="checkbox"/> <input type="checkbox"/>

Note :      = Lot Code

### Absolute Maximum Ratings ( $T_J=25^\circ\text{C}$ Unless Otherwise Noted)

Symbol	Parameter	N-Channel	Unit
$V_{DSS}$	Drain-Source Voltage	40	V
$V_{GSS}$	Gate-Source Voltage	$\pm 20$	
$T_J$	Maximum Junction Temperature	150	$^\circ\text{C}$
$T_{STG}$	Storage Temperature Range	-55 to 150	$^\circ\text{C}$
$I_S$	Diode Continuous Forward Current	$T_c=25^\circ\text{C}$	A
$I_{DM}^{\text{(1)}}$	Pulse Drain Current Tested	$T_c=25^\circ\text{C}$	A
$I_D$	Continuous Drain Current	$T_c=25^\circ\text{C}$	$142^{\text{(1)}}$
		$T_c=100^\circ\text{C}$	136
$P_D$	Maximum Power Dissipation	$T_c=25^\circ\text{C}$	73.5
		$T_c=100^\circ\text{C}$	29.4
$I_D$	Continuous Drain Current	$T_A=25^\circ\text{C}$	39.5
		$T_A=70^\circ\text{C}$	31.6
$P_D$	Maximum Power Dissipation	$T_A=25^\circ\text{C}$	2.5
		$T_A=70^\circ\text{C}$	1.6
$I_{AS}^{\text{(2)}}$	Avalanche Current, Single pulse	$L=0.1\text{mH}$	45
		$L=0.5\text{mH}$	25
$E_{AS}^{\text{(2)}}$	Avalanche Energy, Single pulse	$L=0.1\text{mH}$	101
		$L=0.5\text{mH}$	156

### Thermal Characteristics

Symbol	Parameter	Rating	Unit
$R_{\theta JC}$	Thermal Resistance-Junction to Case	Steady State	$^\circ\text{C/W}$
$R_{\theta JA}^{\text{(3)}}$	Thermal Resistance-Junction to Ambient	Steady State	$^\circ\text{C/W}$

Note ① : Max. current is limited by bonding wire

Note ② : UIS tested and pulse width are limited by maximum junction temperature  $150^\circ\text{C}$

Note ③ : Surface Mounted on 1in<sup>2</sup> FR-4 board with 1oz

# LM40016NAK8A

## N-Channel Electrical Characteristics ( $T_J=25^\circ\text{C}$ Unless Otherwise Noted)

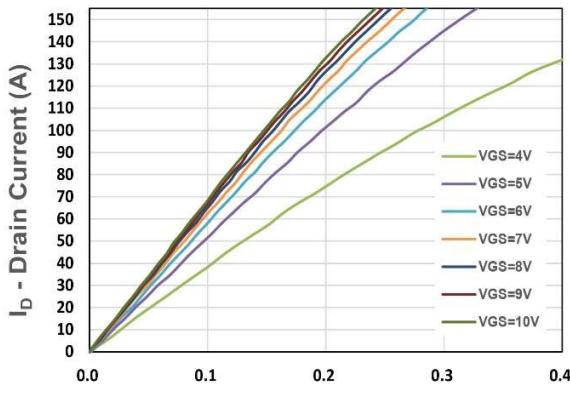
Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
<b>Static Electrical Characteristics</b>						
<b><math>\text{BV}_{\text{DSS}}</math></b>	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$ , $I_{\text{DS}}=250\mu\text{A}$	40	-	-	V
<b><math>I_{\text{DSS}}</math></b>	Zero Gate Voltage Drain Current	$V_{\text{DS}}=32\text{V}$ , $V_{\text{GS}}=0\text{V}$	-	-	1	$\mu\text{A}$
<b><math>V_{\text{GS(th)}}</math></b>	Gate Threshold Voltage	$V_{\text{DS}}=V_{\text{GS}}$ , $I_{\text{DS}}=250\mu\text{A}$	1.2	1.7	2.2	V
<b><math>I_{\text{GSS}}</math></b>	Gate Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$ , $V_{\text{DS}}=0\text{V}$	-	-	$\pm 100$	$\text{nA}$
<b><math>R_{\text{DS(ON)}}^{\circledast}</math></b>	Drain-Source On-state Resistance	$V_{\text{GS}}=10\text{V}$ , $I_{\text{DS}}=20\text{A}$	-	1.3	1.6	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$ , $I_{\text{DS}}=20\text{A}$	-	2	2.5	
<b><math>g_{\text{fs}}</math></b>	Forward Transconductance	$V_{\text{DS}}=5\text{V}$ , $I_{\text{DS}}=20\text{A}$	-	43	-	S
<b>Dynamic Characteristics <sup>®</sup></b>						
<b><math>R_{\text{G}}</math></b>	Gate Resistance	$V_{\text{GS}}=0\text{V}$ , $V_{\text{DS}}=0\text{V}$ , Freq.=1MHz	-	1.8	-	$\Omega$
<b><math>C_{\text{iss}}</math></b>	Input Capacitance	$V_{\text{GS}}=0\text{V}$ , $V_{\text{DS}}=20\text{V}$ , Freq.=1MHz	-	2993	-	$\text{pF}$
<b><math>C_{\text{oss}}</math></b>	Output Capacitance		-	1170	-	
<b><math>C_{\text{rss}}</math></b>	Reverse Transfer Capacitance		-	123	-	
<b><math>t_{\text{d(ON)}}</math></b>	Turn-on Delay Time	$V_{\text{GS}}=10\text{V}$ , $V_{\text{DS}}=20\text{V}$ , $I_{\text{D}}=1\text{A}$ , $R_{\text{GEN}}=1\Omega$	-	18.9	-	$\text{nS}$
<b><math>t_{\text{r}}</math></b>	Turn-on Rise Time		-	14	-	
<b><math>t_{\text{d(OFF)}}</math></b>	Turn-off Delay Time		-	50.6	-	
<b><math>t_{\text{f}}</math></b>	Turn-off Fall Time		-	78.6	-	
<b><math>Q_{\text{g}}</math></b>	Total Gate Charge	$V_{\text{GS}}=10\text{V}$ , $V_{\text{DS}}=20\text{V}$ , $I_{\text{D}}=20\text{A}$	-	69.9	-	$\text{nC}$
<b><math>Q_{\text{gs}}</math></b>	Gate-Source Charge		-	11.7	-	
<b><math>Q_{\text{gd}}</math></b>	Gate-Drain Charge		-	16.7	-	
<b>Source-Drain Characteristics</b>						
<b><math>V_{\text{SD}}^{\circledast}</math></b>	Diode Forward Voltage	$I_{\text{SD}}=1\text{A}$ , $V_{\text{GS}}=0\text{V}$	-	0.7	1.1	V
<b><math>t_{\text{rr}}</math></b>	Reverse Recovery Time	$I_{\text{F}}=10\text{A}$ , $V_{\text{R}}=20\text{V}$	-	44.3	-	$\text{nS}$
<b><math>Q_{\text{rr}}</math></b>	Reverse Recovery Charge		$dI_{\text{F}}/dt=100\text{A}/\mu\text{s}$	31.6	-	$\text{nC}$

Note ④ : Pulse test (pulse width $\leq 300\mu\text{s}$ , duty cycle $\leq 2\%$ ).

Note ⑤ : Guaranteed by design, not subject to production testing.

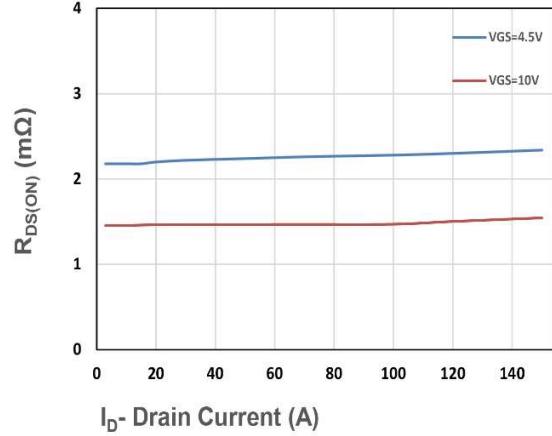
# LM40016NAK8A

## N-Channel Typical Characteristics



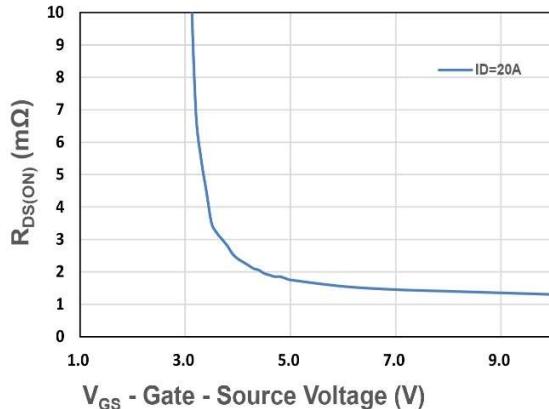
$V_{DS}$  - Drain - Source Voltage (V)

Figure 1. Output Characteristics



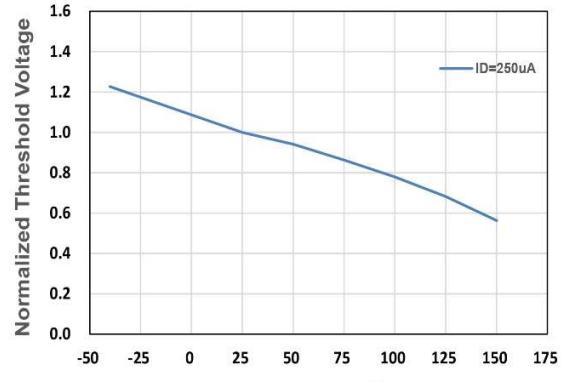
$I_D$ - Drain Current (A)

Figure 2. On-Resistance vs. ID



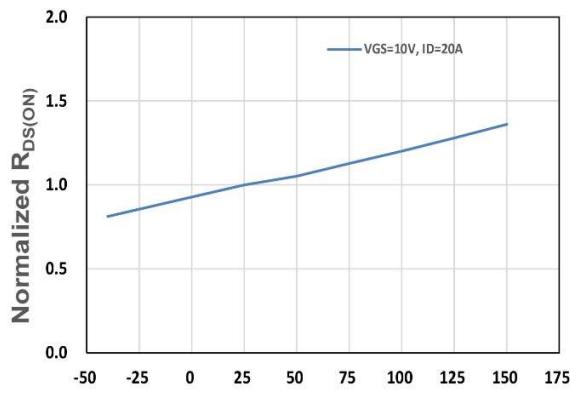
$V_{GS}$  - Gate - Source Voltage (V)

Figure 3. On-Resistance vs. VGS



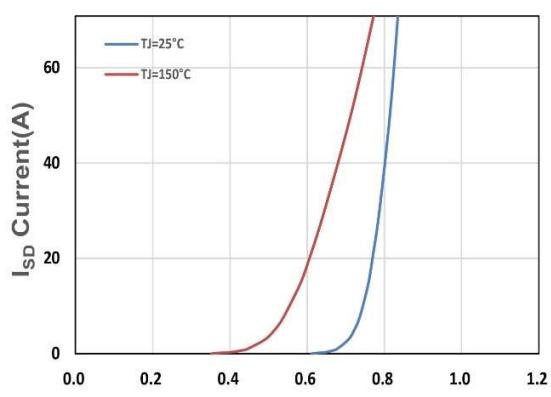
$T_J$ , Junction Temperature(°C)

Figure 4. Gate Threshold Voltage



$T_J$  , Junction Temperature(°C)

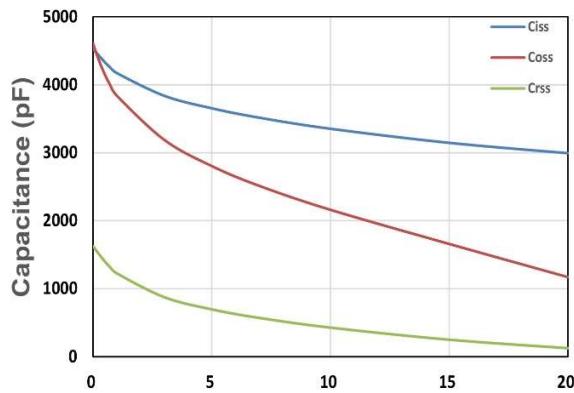
Figure 5. Drain-Source On Resistance



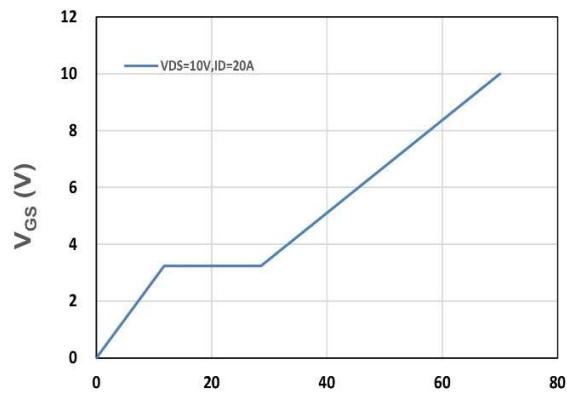
$V_{SD}$ , Source-Drain Voltage(V)

Figure 6. Source-Drain Diode Forward

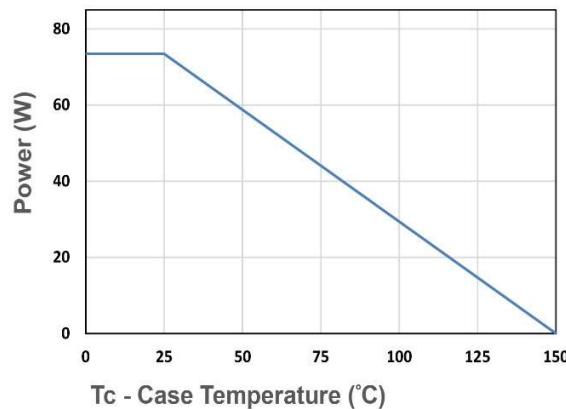
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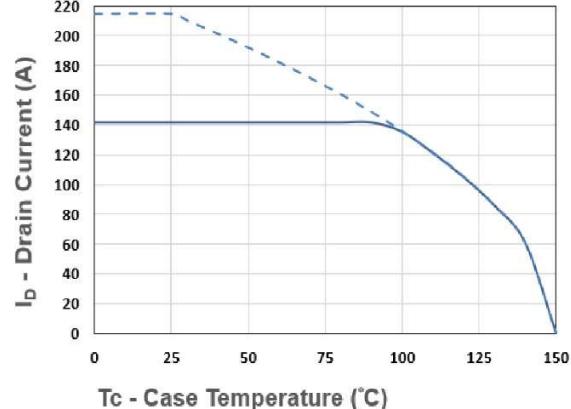
$V_{DS}$  - Drain - Source Voltage (V)  
Figure 7. Capacitance



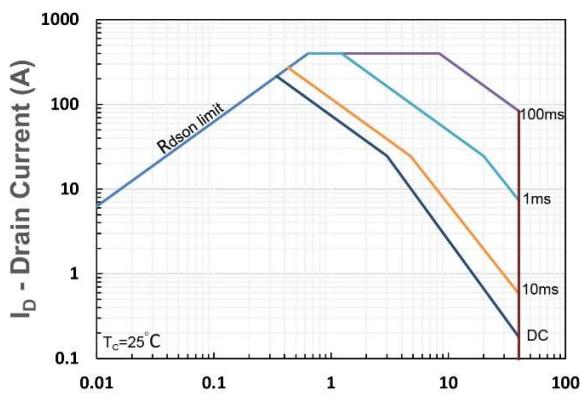
$Q_g$ , Total Gate Charge (nC)  
Figure 8. Gate Charge Characteristics



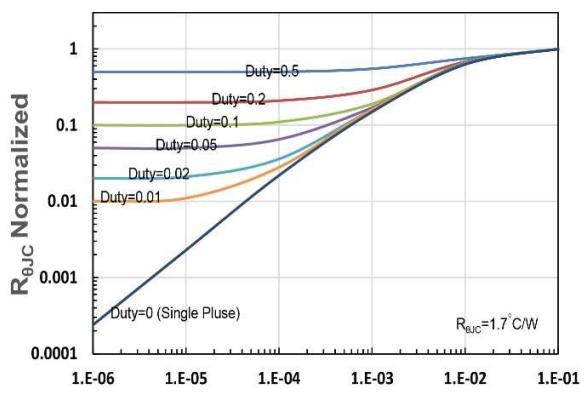
$T_c$  - Case Temperature (°C)  
Figure 9. Power Dissipation



$T_c$  - Case Temperature (°C)  
Figure 10. Drain Current



$V_{DS}$  - Drain-Source Voltage (V)  
Figure 11. Safe Operating Area



$t_1$ , Square Wave Pulse Duration(s)  
Figure 12.  $R_{eJC}$  Transient Thermal Impedance